

Search Notes**Application/Control No.**

10/714,116

Examiner

Chen-Wen Jiang

Applicant(s)/Patent under Reexamination

HAMILTON ET AL.

Art Unit

3744

SEARCHED

Class	Subclass	Date	Examiner
62	186 418 259.2		
361	695 688		
	689 690		
	691 694		
165	104.33		
	80.3	4/5/2007	CJ

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner